LOW-POWER MULTIPLE RS-232 DRIVERS AND RECEIVERS

SLLS294A - APRIL 1998 - REVISED JUNE 1999

- Single-Chip RS-232 Interface for an **External Modem or Other Computer Peripheral Serial Port**
- Designed to Transmit and Receive 4-us Pulses (Equivalent to 256 kbit/s)
- Wide Driver Supply-Voltage Range: 4.75 V to 15 V
- **Driver Output Slew Rates Are Controlled** Internally to 30 V/us Maximum
- Receiver Input Hysteresis . . . 1000 mV **Typical**
- **RS-232 Bus-Pin ESD Protection Exceeds** 15 kV Using Human-Body Model (HBM)
- **Five Drivers and Three Receivers Meet or Exceed the Requirements of TIA/EIA-232-F** and ITU v.28 Standards
- Complements the SN75LP1185
- Designed to Replace the Industry-Standard SN75196 With the Same Flow-Through **Pinout**
- **Package Options Include Plastic Small** Outline (DW), Shrink Small-Outline (DB), Thin Shrink Small-Outline (PW), and **Dual-in-Line (N) Packages**

DB. DW. N. OR PW PACKAGE (TOP VIEW)

				1
V _{CC} [1	\cup	20	V _{DD}
DA1	2		19	DY1
DA2	3		18	DY2
DA3	4		17	DY3
RY1	5		16	RA1
RY2	6		15	RA2
DA4	7		14	DY4
RY3	8		13	RA3
DA5	9		12	DY5
GND [10		11] V _{SS}

description

The SN75LP196 is a low-power bipolar device containing five drivers and three receivers, with 15 kV of ESD protection on the bus pins with respect to each other. Bus pins are defined as those pins that tie directly to the serial-port connector, including GND. The pinout matches the flow-through design of the industry-standard SN75196 and allows easy interconnection of the UART and serial-port connector of the IBM PC/AT and compatibles. This device provides a rugged, low-cost solution for this function with the combination of bipolar processing and 15-kV ESD protection.

The SN75LP196 has internal slew-rate control to provide a maximum rate of change in the output signal of 30 V/μs. The driver output swing is clamped nominally at ±6 V to enable the higher data rates associated with this device and to reduce EMI emissions. Even though the driver outputs are clamped, they can handle voltages up to ±15 V without damage. All the logic inputs can accept 3.3-V or 5-V input signals.

The SN75LP196 complies with the requirements of the TIA/EIA-232-F and the ITU v.28 standards. These standards are for data interchange between a host computer and peripheral at signaling rates up to 20 kbit/s. The switching speeds of the SN75LP196 support rates up to 256 kbit/s with lower capacitive loads (shorter cables).

The SN75LP196 is characterized for operation from 0°C to 70°C.



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Function Tables

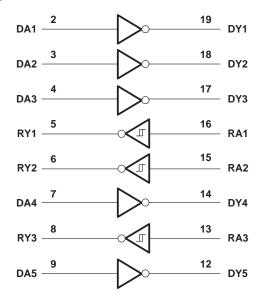
DRIVER

INPUT DA	OUTPUT DY
Н	L
L	Н
Open	L

RECEIVER

INPUT RA	OUTPUT RY
Н	L
L	Н
Open	н

logic diagram (positive logic)



SN75LP196 LOW-POWER MULTIPLE RS-232 DRIVERS AND RECEIVERS

SLLS294A - APRIL 1998 - REVISED JUNE 1999

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Positive supply-voltage range (see Note 1): V _{CC}	–0.5 V to 7 V
V _{DD} (see Note 1)	
Negative supply-voltage range, V _{SS} (see Note 1)	
Input-voltage range, V _I : Receiver (RA)	–30 V to 30 V
Driver (DA)	0.5 V to V _{CC} +0.4 V
Output-voltage range, Vo: Receiver (RY)	
Driver (DY)	
Electrostatic discharge: Bus pins (human-body model) (see Note 2)	Class 3, A: 15 kV
All pins (human-body model) (see Note 2)	Class 3, A: 5 kV
All pins (machine model)	
Package thermal impedance, θ _{JA} (see Notes 3 and 4): DB package	
DW package	97°C/W
N package	67°C/W
PW package	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	
Storage temperature range, T _{stq}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to network ground terminal, unless otherwise noted.

- 2. Per MIL-STD-883 Method 3015.7
- 3. Maximum power dissipation is a function of $T_J(max)$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(max) T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can impact reliability.
- 4. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

		MIN	NOM	MAX	UNIT
Vcc	Supply voltage (see Note 5)	4.75	5	5.25	V
V_{DD}	Supply voltage (see Note 6)	9	12	15	V
VSS	Supply voltage (see Note 6)	-9	-12	-15	V
VIH	High-level input voltage DA	2			V
VIL	Low-level input voltage DA			0.8	V
VI	Receiver input voltage RA	-25		25	V
IOH	High-level output current RY			-1	mA
lOL	Low-level output current RY			2	mA
TA	Operating free-air temperature	0		70	°C

NOTES: 5. V_{CC} cannot be greater than V_{DD}.

6. The device operates down to V_{DD} = V_{CC} and |V_{SS}| = V_{CC}, but supply currents increase and other parameters may vary slightly from the data-sheet limits.



SN75LP196 LOW-POWER MULTIPLE RS-232 DRIVERS AND RECEIVERS

SLLS294A - APRIL 1998 - REVISED JUNE 1999

supply currents over the recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS			TYP	MAX	UNIT	
Complex suggests for Many Land		$V_{DD} = 9 \text{ V}, V_{SS} = -9 \text{ V}$			1000		
Supply current for V _{CC} , I _{CC}	No load,	$V_{DD} = 12 \text{ V}, V_{SS} = -12 \text{ V}$			1000	μΑ	
Ι Δι	All inputs at	$V_{DD} = 9 \text{ V}, V_{SS} = -9 \text{ V}$			800		
Supply current for V _{DD} , I _{DD}	minimum VOH or	$V_{DD} = 12 \text{ V}, V_{SS} = -12 \text{ V}$			800	μΑ	
Cumply current for \/o = lee	maximum V _{OL}	$V_{DD} = 9 \text{ V}, V_{SS} = -9 \text{ V}$			-800		
Supply current for VSS, ISS		V _{DD} = 12 V, V _{SS} = -12 V			-800	μΑ	

driver electrical characteristics over the recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CON	DITIONS		MIN	TYP	MAX	UNIT
Vou	High-level output voltage	V _{IL} = 0.8 V,	V _{DD} = 9 V,	$V_{SS} = -9 V$,	See Note 7	5	5.8	6.6	V
VOH	r ligir-level output voltage	$R_L = 3 k\Omega$, See Figure 1	V _{DD} = 12 V,	$V_{SS} = -12 V$,	See Note 8	5	5.8	6.6	V
VOL	Low-level output voltage	V _{IH} = 2 V,	V _{DD} = 9 V,	$V_{SS} = -9 V$,	See Note 7	- 5	-5.8	-6.9	V
VOL	Low-level output voltage	ige $R_L = 3 kΩ$, See Figure 1	V _{DD} = 12 V,	$V_{SS} = -12 V$,	See Note 8	-5	-5.8	-6.9	V
lΗ	High-level input current	V _I at V _{CC}					1	μΑ	
IIL	Low-level input current	V _I at GND				-1	μΑ		
los(H)	Short-circuit high-level output current	$V_O = GND \text{ or } V_{SS}$	$V_O = GND \text{ or } V_{SS},$ See Fig		and Note 9		-30	-55	mA
los(L)	Short-circuit low-level output current	$V_O = GND \text{ or } V_{DD},$		See Figure 2 a	and Note 9		30	55	mA
r _O	Output resistance	$V_{DD} = V_{SS} = V_{CC}$; = 0,	$V_0 = -2 \text{ V to } 2$	2 V	300			Ω

NOTES: 7. Minimum RS-232 driver output voltages are not attained with ±5-V supplies. With V_{DD} less than V_{CC} + 2 V, the supply currents may increase. For RS-232 compliant output swings and minimum power consumption, V_{DD} ≥ V_{CC} + 2 V.

9. Not more than one output should be shorted at one time.

^{8.} Maximum output swing is nominally clamped at ±6 V to enable the higher data rates associated with this device and to reduce EMI emissions. The driver outputs may slightly exceed the maximum output voltage over the full V_{CC} and temperature ranges.

SN75LP196 LOW-POWER MULTIPLE RS-232 DRIVERS AND RECEIVERS

SLLS294A - APRIL 1998 - REVISED JUNE 1999

driver switching characteristics over operating free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPHL	Propagation delay time, high- to low-level output	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega, C$	R_L = 3 kΩ to 7 kΩ, C_L = 15 pF, See Figure 1			1600	ns
^t PLH	Propagation delay time, low- to high-level output	$R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega, C$	C _L = 15 pF, See Figure 1	300	800	1600	ns
		V _{CC} = 5 V, V _{DD} = 12 V,	Using V _{TR} = 10%-to-90% transition region, Driver speed = 250 kbit/s, C _L = 15 pF	375		2240	
tTLH	Transition time, low- to high-level output	$V_{SS} = -12 \text{ V},$ $R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	Using $V_{TR} = \pm 3 \text{ V}$ transition region, Driver speed = 250 kbit/s, $C_L = 15 \text{ pF}$	200		1500	ns
		See Figure 1 and Note 10	Using $V_{TR} = \pm 3 \text{ V}$ transition region, Driver speed = 125 kbit/s, $C_L = 2500 \text{ pF}$			2750	
		V _{CC} = 5 V, V _{DD} = 12 V,	Using V _{TR} = 10%-to-90% transition region, Driver speed = 250 kbit/s, C _L = 15 pF	375		2240	
tTHL	Transition time, high- to low-level output	$V_{SS} = -12 \text{ V},$ $R_L = 3 \text{ k}\Omega \text{ to } 7 \text{ k}\Omega,$	Using $V_{TR} = \pm 3 \text{ V}$ transition region, Driver speed = 250 kbit/s, $C_L = 15 \text{ pF}$	200		1500	ns
		See Figure 1 and Note 10	Using $V_{TR} = \pm 3 \text{ V}$ transition region, Driver speed = 125 kbit/s, $C_L = 2500 \text{ pF}$			2750	
SR	Output slew rate	V _{CC} = 5 V, V _{DD} = 12 V, V _{SS} = -12 V,	Using $V_{TR} = \pm 3 \text{ V}$ transition region, Driver speed = 0 to 250 kbit/s, $C_L = 15 \text{ pF}$	4	20	30	V/μs

NOTE 10: Maximum output swing is limited to ±6 V to enable the higher data rates associated with this device and to reduce EMI emissions.

receiver electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST	T CONDITIONS	MIN	TYP	MAX	UNIT
V _{IT+}	Positive-going input threshold voltage	See Figure 3		1.6	2	2.55	V
V _{IT} -	Negative-going input threshold voltage	See Figure 3		0.6	1	1.45	V
VHYS	Input hysteresis, V _{IT+} V _{IT-}	See Figure 3		750	1000		mV
Vон	High-level output voltage	I _{OH} = -1 mA		2.5	3.9		V
VOL	Low-level output voltage	I _{OL} = 2 mA			0.33	0.5	V
l High level input gurrent	High-level input current	V _I = 3 V		0.43	0.6	1	mA
IН	riign-ieveriiiput current	V _I = 25 V		3.6	5.1	8.3	IIIA
1	Low-level input current	V _I = 3 V		-0.43	-0.6	-1	mA
¹IL	Low-level input current	V _I = 25 V		-3.6	-5.1	-8.3	IIIA
IOS(H)	Short-circuit high-level output current	V _O = 0,	See Figure 5 and Note 9			-20	mA
I _{OS(L)}	Short-circuit low-level output current	$V_O = V_{CC}$	See Figure 5 and Note 9			20	mA
R _{IN}	Input resistance	$V_I = \pm 3 \text{ V to } \pm 25 \text{ V}$		3	5	7	kΩ

NOTE 9: Not more than one output should be shorted at one time.

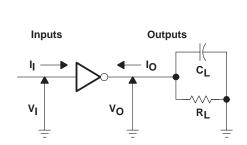


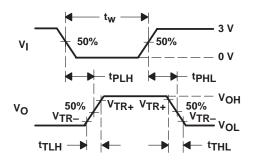
SLLS294A - APRIL 1998 - REVISED JUNE 1999

receiver switching characteristics over operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 4)

	PARAMETER	MIN	TYP	MAX	UNIT
tPHL	Propagation delay time, high- to low-level output		400	900	20
tPLH	Propagation delay time, low- to high-level output		400	900	ns
tTLH	Transition time, low- to high-level output		200	450	20
tTHL	Transition time, high- to low-level output		200	400	ns
tsk(p)	Pulse skew tpLH - tpHL		200	425	ns

PARAMETER MEASUREMENT INFORMATION





NOTES: A. The pulse generator has the following characteristics:

For C_L < 1000 pF: t_W = 4 μ s, PRR = 250 kbit/s, Z_O = 50 Ω , t_f = t_f < 50 ns. For C_L = 2500 pF: t_W = 8 μ s, PRR = 125 kbit/s, Z_O = 50 Ω , t_f = t_f < 50 ns.

B. C_L includes probe and jig capacitance.

Figure 1. Driver Parameter Test Circuit and Waveform

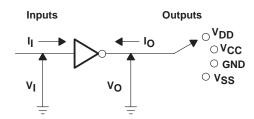


Figure 2. Driver IOS Test

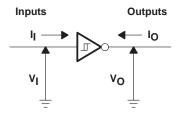
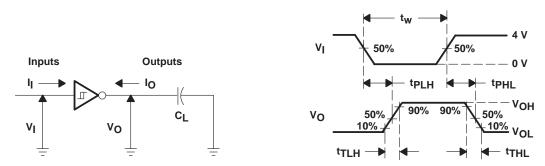


Figure 3. Receiver VIT Test

SLLS294A - APRIL 1998 - REVISED JUNE 1999

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The pulse generator has the following characteristics: $t_W = 4 \mu s$, PRR = 250 kbit/s, $Z_O = 50 \Omega$, $t_T = t_f < 50 ns$.

B. C_L includes probe and jig capacitance.

Figure 4. Receiver Parameter Test Circuit and Waveform

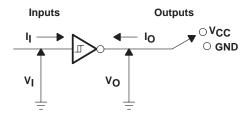


Figure 5. Receiver IOS Test

APPLICATION INFORMATION

Diodes placed in series with the V_{DD} and V_{SS} leads protect the SN75LP196 in the fault condition in which the device outputs are shorted to ± 15 V and the power supplies are at low voltage and provide low-impedance paths to ground (see Figure 6).

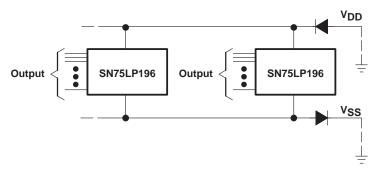


Figure 6. Power-Supply Protection to Meet Power-Off Fault Conditions of EIA/TIA-232-F

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